

1. SUBSTRATE SAPPHIRE (AI2O3)



2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN ≤3.5 ARCMIN

3. COATING (APPLY ACROSS CLEAR APERTURE)

S1: R(ABS) ≤ 1.5% FROM 750-800nm @ 0° AOI R(ABS) ≤ 1.0% FROM 800-1550nm @ 0° AOI R(AVG) ≤ 0.7% FROM 750-1550nm @ 0° AOI

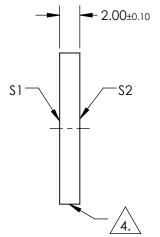
S2: R(ABS) ≤ 1.5% FROM 750-800nm @ 0° AOI R(ABS) ≤ 1.0% FROM 800-1550nm @ 0° AOI R(AVG) ≤ 0.7% FROM 750-1550nm @ 0° AOI



4. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE

5. ROHS COMPLIANT

DNS	Ø 15.00±0.25



	S1	\$2]			FICATIONS SUBJECT TO CHANGE WITHOUT NC NSIONS ARE FOR REFERENCE ONLY	OTICE
SHAPE	PLANO	PLANO					
CLEAR APERTURE	Ø13.5	Ø13.5				Edmund Optics	C ®
SURFACE FLATNESS	2λ	2λ					3
SURFACE ROUGHNESS	0.1 MICRONS PER INCH	0.1 MICRONS PER INCH				15mm DIAMETER, NIR II COATED SAPPH	
SURFACE QUALITY	80-50	80-50				WINDOW	
BIREFRINGENCE (n _o -n _e)	0.008	0.008]	1			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	36571	Sheet 1 Of 1